

| | | | | |
|-----------------------------------|---------------------------------------|--|----------------------------------------------------------------|-------------|
| Notice of References Cited | Application/Control No. 10/655,112 | | Applicant(s)/Patent Under Reexamination CHERMACK, DARREN P. | |
| | Examiner Victor K. Hwang | | Art Unit 3764 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--------------------------------------------------|-----------------|--------------------------|----------------|
| * | A | US-850,964 | 04-1907 | Pelletier et al. | 482/108 |
| * | B | US-5,879,274 | 03-1999 | Mattox, E. Michael | 482/107 |
| * | C | US-6,540,650 B1 | 04-2003 | Krull, Mark A. | 482/107 |
| * | D | US-6,656,093 B2 | 12-2003 | Chen, Paul | 482/108 |
| * | E | US-D498,272 S | 11-2004 | Sanford-Schwentke et al. | D21/681 |
| * | F | US-6,899,661 B1 | 05-2005 | Krull, Mark A. | 482/107 |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--------------------------------------------------|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|-------------------------------------------------------------------------------------------|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.